Notice of References Cited Application/Control No. 10/605,058 Applicant(s)/Patent Under Reexamination DELINE, JONATHAN Examiner Khai M. Nguyen U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination DELINE, JONATHAN Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,223,029 B1	04-2001	Stenman et al.	455/420
*	В	US-2003/0003907 A1	01-2003	Lai et al.	455/425
	С	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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